



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{DSS}	R _{DS(ON)} Max	I _D Max T _C = +25°C
30V	$6.5 \text{m}\Omega$ @ $V_{GS} = 10V$	46.2A
30 V	$10m\Omega @ V_{GS} = 4.5V$	37.0A

Description

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

- Backlighting
- Power Management Functions
- DC-DC Converters

V-DFN3030-8 (Type Q)

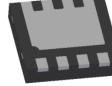
Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

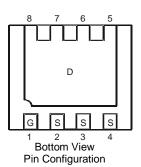
Mechanical Data

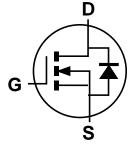
- Case: V-DFN3030-8 (Type Q)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.0172 grams (Approximate)











Equivalent Circuit

Ordering Information (Note 4)

Top View

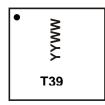
Part Number	Case	Packaging
DMT3006LDK-7	V-DFN3030-8 (Type Q)	3,000/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information

V-DFN3030-8 (Type Q)



T39 = Product Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 17 for 2017) WW = Week Code (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Continuous Drain Current V _{GS} = 10V	$T_A = +25$ °C $T_A = +70$ °C (Note 6)	I _D	17.1 13.7	А
	$T_C = +25$ °C $T_C = +70$ °C	I _D	46.2 37.0	А
Maximum Continuous Body Diode Forward Current (Note 6	Is	2	Α	
Pulsed Drain Current (10µS Pulse, Duty Cycle = 1%)		I _{DM}	80	Α
Avalanche Current (Note 7) L = 0.1mH		I _{AS}	25	Α
Avalanche Energy (Note 7) L = 0.1mH		E _{AS}	31	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		P_D	1.1	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	116	°C/W
Total Power Dissipation (Note 6)		P _D	2.8	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	44	°C/W
Thermal Resistance, Junction to Case	$R_{\theta JC}$	6	*C/vv	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics (@ $T_A = +25$ °C, unless otherwise specified.)

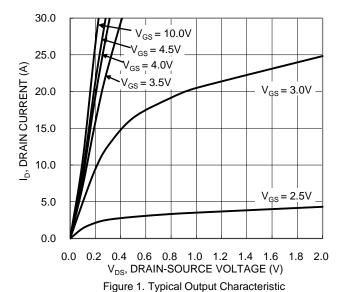
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$		
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	1	1	1	μΑ	$V_{DS} = 24V, V_{GS} = 0V$		
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = +20V, V_{DS} = 0V$ $V_{GS} = -16V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)								
Gate Threshold Voltage	V _{GS(TH)}	1.0	_	3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		
Static Drain-Source On-Resistance		1	5.5	6.5	mΩ	$V_{GS} = 10V, I_D = 12A$		
Static Diani-Source On-Nesistance	RDS(ON)		7.5	10		$V_{GS} = 4.5V, I_D = 12A$		
Diode Forward Voltage	V_{SD}	1	_	1.0	V	$V_{GS} = 0V, I_{S} = 2A$		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	C _{iss}		1,155	_		V _{DS} = 15V, V _{GS} = 0V, f = 1.0MHz		
Output Capacitance	Coss	1	456	_	pF			
Reverse Transfer Capacitance	Crss		72	_				
Gate Resistance	R_{g}	1	1.6		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$		
Total Gate Charge (V _{GS} = 10V)	Qg	1	16.7	_				
Total Gate Charge (V _{GS} = 4.5V)	Q_{g}	1	8.4		nC	Vpp = 15V. lp = 9A		
Gate-Source Charge	Q_{gs}		2.2	_	IIC	VDD = 15V, ID = 9A		
Gate-Drain Charge	Q_{gd}	1	3.5	_				
Turn-On Delay Time	t _{D(ON)}	1	3.5	_				
Turn-On Rise Time	t _R	_	5.5	_		$V_{DD} = 15V, V_{GS} = 10V,$ $R_g = 3\Omega, I_D = 9A$		
Turn-Off Delay Time	t _{D(OFF)}	_	13.5	_	ns			
Turn-Off Fall Time	t _F	_	4.6	_				
Body Diode Reverse Recovery Time	t _{RR}	_	19.3	_	ns	1 1 5 A di/dt 100 \(\frac{1}{2} \)		
Body Diode Reverse Recovery Charge	Q _{RR}	_	8.6	_	nC	I _F = 1.5A, di/dt = 100A/μs		

5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

- 6. Device mounted on 4.75 inches by 4.5 inches FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
- 8. Short duration pulse test used to minimize self-heating effect.

 9. Guaranteed by design. Not subject to product testing.





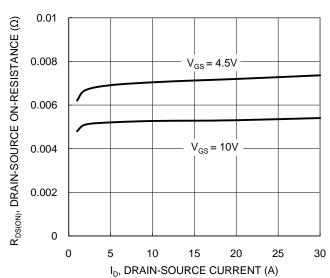


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

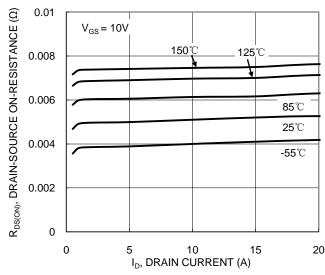


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

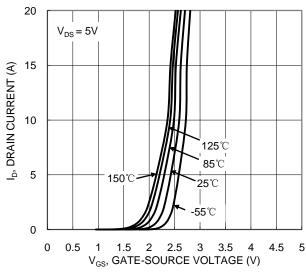


Figure 2. Typical Transfer Characteristic

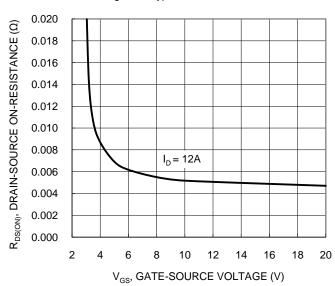
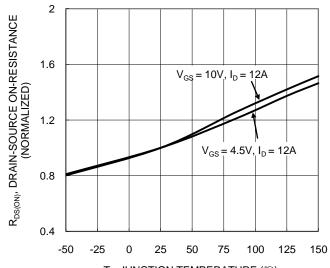


Figure 4. Typical Transfer Characteristic



 $\mathsf{T_{J}},\mathsf{JUNCTION}$ TEMPERATURE (°C) Figure 6. On-Resistance Variation with Temperature





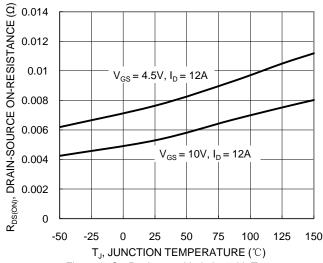
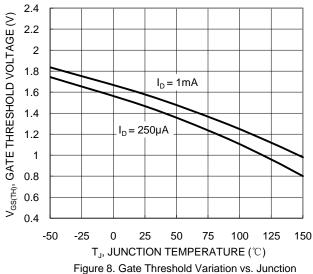
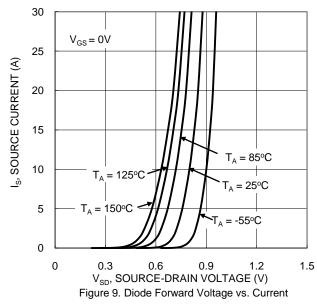


Figure 7. On-Resistance Variation with Temperature



Temperature



10 8 6 $V_{GS}(V)$ 4 $V_{DS} = 15V, I_{D} = 12A$ 2 0 0 5 10 15 20 25 Q_{α} (nC) Figure 11. Gate Charge

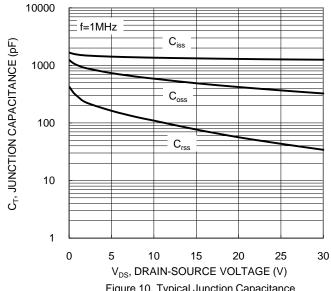
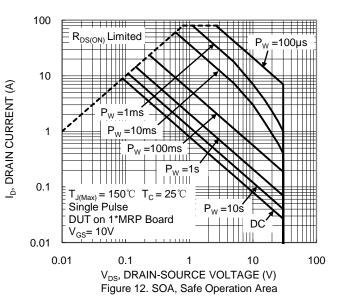


Figure 10. Typical Junction Capacitance





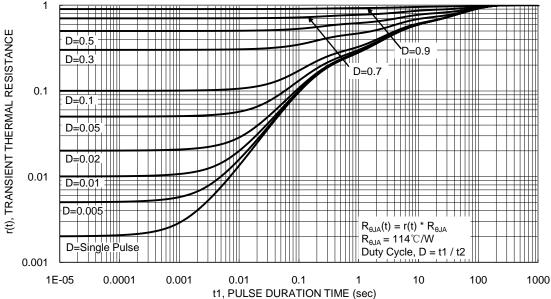


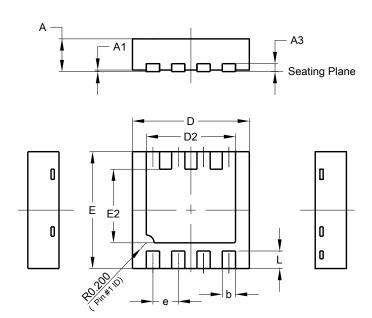
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type Q)

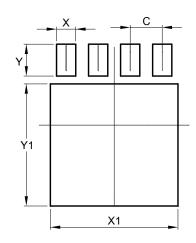


V-DFN3030-8 (Type Q)					
Dim	Min	Max	Тур		
Α	0.77	0.83	0.80		
A1	0.00	0.05	0.02		
A3			0.203		
b	0.29	0.39	0.34		
D	2.95	3.05	3.00		
D2	2.19	2.39	2.29		
Е	2.95	3.05	3.00		
E2	1.64	1.84	1.74		
е		-	0.65		
L	0.40	0.50	0.45		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type Q)



Dimensions	Value (in mm)		
С	0.650		
Х	0.390		
X1	2.590		
Y	0.650		
Y1	2.490		



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